

<b>Notice of References Cited</b>	Application/Control No. 10/737,229	Applicant(s)/Patent Under Reexamination AYER ET AL.	
	Examiner Navin Natnithithadha	Art Unit 3735	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0216622	11-2003	Meron et al.	600/300
*	B	US-3,719,183	03-1973	Schwartz, Howard S.	600/302
*	C	US-6,440,069	08-2002	Raymond et al.	600/300
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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